Application/Control No. Applicant(s)/Patent Under Reexamination 10/649,085 CHEN, SEAN S. Notice of References Cited Art Unit Examiner Page 1 of 1 Joseph Chang 2817 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,356,161 B1 03-2002 Nolan et al. Α 331/176 US-6,456,170 B1 В 09-2002 Segawa et al. 331/143 US-5,384,554 A 01-1995 С Abernethy, Brian 331/153 D US-US-Ε US-F US-G US-Н US-1 US- . US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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